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Attorney Docket No. 02345/17A

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant(s) : Rainer LOESCH, et al.
 Serial No. : 09/750,837
 Filed : December 28, 2000
 Title : CALIBRATED SCALE IN THE NANOMETER RANGE
 FOR TECHNICAL DEVICES USED FOR THE HIGH-
 RESOLUTION OR ULTRAHIGH-RESOLUTION IMAGING
 OF STRUCTURES
 Art Unit : 1774
 Examiner : Lawrence D. Ferguson

Commissioner for Patents
 P.O. Box 1450
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 facsimile (using facsimile number +1-703-872-8306 as instructed by
 the Office Action) to the Commissioner for Patents for the United
 States Patent and Trademark Office on:

Date: October 20, 2005

By: 
Linda M. Shudy (Reg. No. 47,084)

RESPONSE TO OFFICE ACTION

SIR:

In response to the Office Action dated April 20, 2005, please reconsider the above-identified application based on the following remarks.

Amendments to the Claims are reflected in the listing of claims, which begins on page 2 of this paper.

Remarks begin on page 4 of this paper.